## Application/Control No. Applicant(s)/Patent Under Reexamination YAMAMOTO ET AL. Examiner Timothy L Rude Applicant(s)/Patent Under Reexamination YAMAMOTO ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6372354	04-2002	Park et al	428/477
	В	US-4422721	12-1983	Hahn et al	350/164
	С	US-5150004	09-1992	Tong et al	313/479
	D	US-2001/0024719	09-2001	Lewis	428/335
	Е	US-6348960	02-2002	Etori et al	349/112
	F	US-6384884	05-2002	Nakamura et al	349/113
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

	The state of the s					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.